

TSL208R 512 × 1 Linear Sensor Array

General Description

The TSL208R linear sensor array consists of a 512×1 array of photodiodes and associated charge amplifier circuitry. The pixels measure $120\mu m$ (H) by $70\mu m$ (W) with $125\mu m$ center-to-center spacing and $55\mu m$ spacing between pixels. Operation is simplified by internal control logic that requires only a serial-input (SI) signal and a clock.

The TSL208R is intended for use in a wide variety of applications including mark detection and code reading, optical character recognition (OCR) and contact imaging, edge detection and positioning as well as optical linear and rotary encoding.

Ordering Information and Content Guide appear at end of datasheet.

Key Benefits & Features

The benefits and features of the TSL208R, 512x1 Linear Sensor Array are listed below:

Figure 1: Added Value of Using TSL208R

Benefits	Features
Provides High Density Pixel Count	512 x 1 Sensor-Element Organization
Enables High Resolution Scanning	• 200 Dots-Per-Inch (DPI) Sensor Pitch
Enables Capacitive Threshold Sensing	High Linearity and Uniformity
Provides Full Dynamic Range	Rail-to-Rail Output Swing

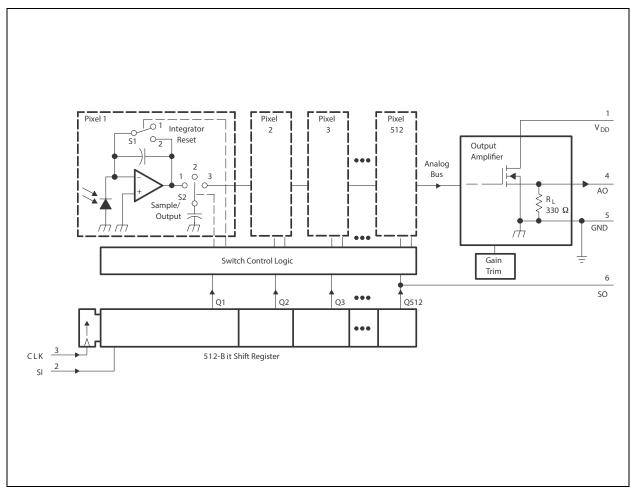
- Wide Dynamic Range: 2000:1 (66dB)
- Output Referenced to Ground
- Low Image Lag: 0.5% Typical
- Operation to 5MHz
- Single 5V Supply
- Replacement for TSL208



Block Diagram

The functional blocks of this device are shown below:







Pin Assignment

The TSL208R pin assignments are described below:

Figure 3: Pin Diagram (Top View)

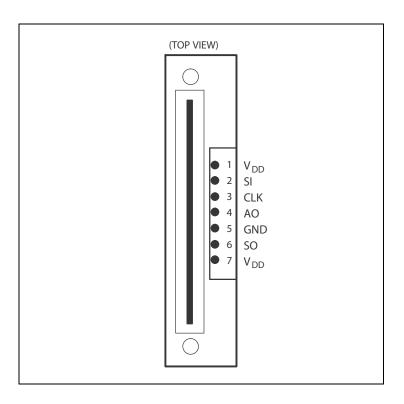


Figure 4: Pin Descriptions

Terminal			- Description		
Name	No.	I/O	Description		
V _{DD}	1, 7	I	Supply voltage for both analog and digital circuits.		
SI	2	I	Serial input. SI defines the start of the data out sequence.		
CLK	3	I	Clock. The clock controls the charge transfer, pixel output and reset.		
AO	4	0	Analog output.		
GND	5	I	Ground (substrate). All voltages are referenced to the substrate.		
SO	6	0	Serial output. SO signals the end of the data out sequence.		

Detailed Description

The sensor consists of 512 photodiodes arranged in a linear array. Light energy impinging on a photodiode generates photocurrent, which is integrated by the active integration circuitry associated with that pixel. During the integration period, a sampling capacitor connects to the output of the integrator through an analog switch. The amount of charge accumulated at each pixel is directly proportional to the light intensity and the integration time. The integration time is the interval between two consecutive output periods.

The output and reset of the integrators is controlled by a 512-bit shift register and reset logic. An output cycle is initiated by clocking in a logic 1 on SI for one positive going clock edge (see Figure 10 and Figure 11)¹. As the SI pulse is clocked through the 512-bit shift register, the charge on the sampling capacitor of each pixel is sequentially connected to a charge-coupled output amplifier that generates a voltage output, AO. When the bit position goes low, the pixel integrator is reset. On the 513th clock rising edge, the SI pulse is clocked out of the shift register and the output assumes a high-impedance state. Note that this 513th clock pulse is required to terminate the output of the 512th pixel and return the internal logic to a known state. A subsequent SI pulse can be presented as early as the 514th clock pulse, thereby initiating another pixel output cycle.

The voltage developed at analog output (AO) is given by:

(EQ1)
$$V_{out} = V_{drk} + (R_e) (E_e) (t_{int})$$

where:

- V_{out} is the analog output voltage for white condition
- V_{drk} is the analog output voltage for dark condition
- + R_e is the device responsivity for a given wavelength of light given in V/(μ J/cm²)
- E_e is the incident irradiance in μ W/cm²
- t_{int} is integration time in seconds

AO is driven by a source follower with an internal 330Ω pulldown resistor (no external resistor is required). The output is nominally 0V for no light input, 2V for normal white-level, and 3.4V for saturation light level. When the device is not in the output phase, AO is in a high impedance state.

A 0.1 μ F bypass capacitor should be connected between V_{DD} and ground as close as possible to the device.

^{1.} For proper operation, after meeting the minimum hold time condition, SI must go low before the next rising edge of the clock.



Absolute Maximum Ratings

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under Electrical Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 5: Absolute Maximum Ratings

Symbol	Parameter	Min	Мах	Unit
V _{DD}	Supply voltage range	-0.3	6	V
VI	Input voltage range	-0.3	V _{DD} + 0.3V	V
I _{IK}	Input clamp current, $(V_I < 0)$ or $(V_I > V_{DD})$	-20	20	mA
I _{ОК}	Output clamp current, $(V_O < 0)$ or $(V_O > V_{DD})$	-25	25	mA
V _O	Voltage range applied to any output in the high impedance or power-off state		V _{DD} + 0.3V	V
۱ ₀	Continuous output current, $(V_0 = 0 \text{ to } V_{DD})$	-25	25	mA
	Continuous current through V _{DD} or GND	-100	100	mA
Ι _Ο	Analog output current range	-25	25	mA
T _A	Operating free-air temperature range		85	°C
T _{STRG}	Storage temperature range	-25	85	°C
	Lead temperature on connection pad for 10 seconds		260	°C
ESD _{HBM}	ESD tolerance, human body model	-	±2000	V



Electrical Characteristics

All limits are guaranteed. The parameters with min and max values are guaranteed with production tests or SQC (Statistical Quality Control) methods.

Figure 6:

Recommended Operating Conditions (see Figure 10 and Figure 11)

Symbol	Parameter	Min	Nom	Max	Unit
V _{DD}	Supply voltage	4.5	5	5.5	V
VI	Input voltage	0		V _{DD}	V
V _{IH}	High-level input voltage	2		V _{DD}	V
V _{IL}	Low-level input voltage	0		0.8	V
λ	Wavelength of light source	400		1000	nm
f _{clock}	Clock frequency	5		5000	kHz
t _{int}	Sensor integration time	0.1026		100	ms
T _A	Operating free-air temperature	0		70	°C
CL	Load capacitance			330	pF

Figure 7:

Electrical Characteristics at $f_{clock} = 1$ MHz, $V_{DD} = 5$ V, $T_A = 25$ °C, $\lambda_p = 640$ nm, $t_{int} = 5$ ms, $R_L = 330\Omega$, $E_e = 18\mu$ W/cm² (unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _{out}	Analog output voltage (white, average over 512 pixels)	See note (1)	1.6	2	2.4	V
V _{drk}	Analog output voltage (dark, average over 512 pixels)		0	50	150	mV
PRNU	Pixel response nonuniformity	See notes (2), (3)		±7%	±20%	
	Nonlinearity of analog output voltage	See note (3)		±0.4%		FS
	Output noise voltage	See note (4)		1		mVrms
R _e	Responsivity		16	22	28	V/ (µJ/cm ²)
SE	Saturation exposure	See note (5)		155		nJ/cm ²
V _{sat}	Analog output saturation voltage		2.5	3.4		V
DSNU	Dark signal nonuniformity	All pixels ⁽⁶⁾		25	120	mV

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
IL	Image lag	See note (7)		0.5%		
I _{DD}	Supply current, output idle			28	45	mA
I _{IH}	High-level input current	$V_{I} = V_{DD}$			10	μΑ
I _{IL}	Low-level input current	V ₁ = 0			10	μΑ
V _{OH}	High level output voltage SO	l _O = 50μA	4.5	4.95		v
*OH		Ι _Ο = 4μΑ		4.6		
V _{OL}	Low level output voltage SO	l _O = 50μA		0.01	0.1	v
VOL	Low level output voltage 50	Ι _Ο = 4μΑ		0.4		v
C _{i(SI)}	Input capacitance, SI			40		pF
C _{i(CLK)}	Input capacitance, CLK			40		pF

Note(s):

- 1. The array is uniformly illuminated with a diffused LED source having a peak wavelength of 640nm.
- 2. PRNU is the maximum difference between the voltage from any single pixel and the average output voltage from all pixels of the device under test when the array is uniformly illuminated at the white irradiance level. PRNU includes DSNU.
- 3. Nonlinearity is defined as the maximum deviation from a best-fit straight line over the dark-to-white irradiance levels, as a percent of analog output voltage (white).
- 4. RMS noise is the standard deviation of a single-pixel output under constant illumination as observed over a 5-second period.

5. Minimum saturation exposure is calculated using the minimum $V_{sat'}$ the maximum $V_{drk'}$ and the maximum R_e .

6. DSNU is the difference between the maximum and minimum output voltage in the absence of illumination.

7. Image lag is a residual signal left in a pixel from a previous exposure. It is defined as a percent of white-level signal remaining after a pixel is exposed to a white condition followed by a dark condition:

IL=
$$\frac{V_{out(IL)} - V_{drk}}{V_{out(white)} - V_{drk}} \times 100$$

Figure 8: Timing Requirements (see Figure 10 and Figure 11)

Symbol	Parameter	Min	Nom	Max	Unit
t _{su(SI)}	Setup time, serial input ⁽¹⁾	20			ns
t _{h(SI)}	Hold time, serial input ^{(1), (2)}	0			ns
t _w	Pulse duration, clock high or low	50			ns
t _r , t _f	Input transition (rise and fall) time	0		500	ns

Note(s):

1. Input pulses have the following characteristics: $t_r = 6ns$, $t_f = 6ns$.

2. SI must go low before the rising edge of the next clock pulse.

Figure 9:

Dynamic Characteristics over Recommended Ranges of Supply Voltage and Operating Free-Air Temperature (see Figure 11)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ts	Analog output settling time to ±1%	C _L = 10pF		185		ns
t _{pd(SO)}	Propagation delay time, SO			50		ns

Typical Characteristics

Figure 10: Timing Waveforms (each section)

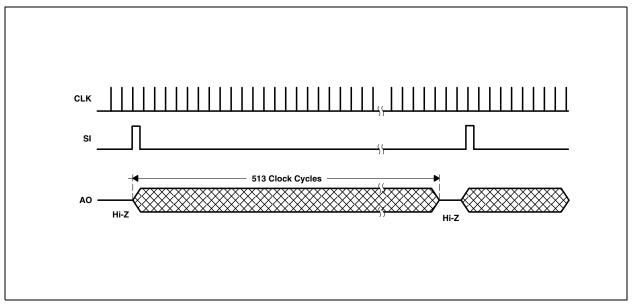


Figure 11: Operational Waveforms (each section)

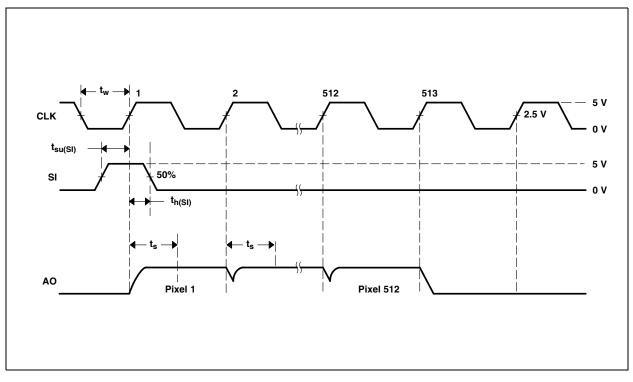
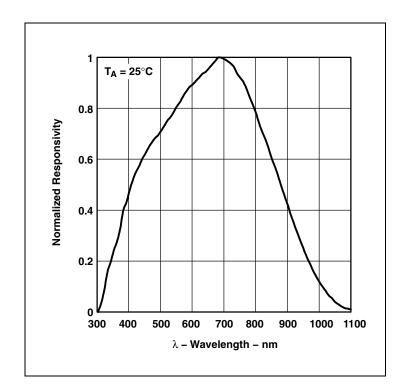


Figure 12: Photodiode Spectral Responsivity



Application Information

Integration Time

The integration time of the linear array is the period during which light is sampled and charge accumulates on each pixel's integrating capacitor. The flexibility to adjust the integration period is a powerful and useful feature of the ams AG TSL2xx linear array family. By changing the integration time, a desired output voltage can be obtained on the output pin while avoiding saturation for a wide range of light levels.

Each pixel of the linear array consists of a light-sensitive photodiode. The photodiode converts light intensity to a voltage. The voltage is sampled on the Sampling Capacitor by closing switch S2 (position 1) (see Figure 2). Logic controls the resetting of the Integrating Capacitor to zero by closing switch S1 (position 2).

At SI input (Start Integration), pixel 1 is accessed. During this event, S2 moves from position 1 (sampling) to position 3 (holding). This holds the sampled voltage for pixel 1. Switch S1 for pixel 1 is then moved to position 2. This resets (clears) the voltage previously integrated for that pixel so that pixel 1 is now ready to start a new integration cycle. When the next clock period starts, the S1 switch is returned to position 1 to be ready to start integrating again. S2 is returned to position 1 to start sampling the next light integration. Then the next pixel starts the same procedure. The integration time is the time from a specific pixel read to the next time that pixel is read again. If either the clock speed or the time between successive SI pulses

is changed, the integration time will vary. After the final (n^{th}) pixel in the array is read on the output, the output goes into a high-impedance mode. A new SI pulse can occur on the (n+1) clock causing a new cycle of integration/output to begin. Note that the time between successive SI pulses must not exceed the maximum integration time of 100ms.

The minimum integration time for any given array is determined by time required to clock out all the pixels in the array and the time to discharge the pixels. The time required to discharge the pixels is a constant. Therefore, the minimum integration period is simply a function of the clock frequency and the number of pixels in the array. A slower clock speed increases the minimum integration time and reduces the maximum light level for saturation on the output. The minimum integration time shown in this data sheet is based on the maximum clock frequency of 5MHz.

The minimum integration time can be calculated from the equation:

(EQ2)
$$T_{int(min)} = \left(\frac{1}{maximum clock frequency}\right) \times n$$

where:

n is the number of pixels

In the case of the TSL208R, the minimum integration time would be:

 $T_{int(min)} = 200 \text{ns} \times 512 = 102.4 \mu \text{s}$

It is important to note that not all pixels will have the same integration time if the clock frequency is varied while data is being output.

It is good practice on initial power up to run the clock (n+1) times after the first SI pulse to clock out indeterminate data from power up. After that, the SI pulse is valid from the time following (n+1) clocks. The output will go into a high-impedance state after the n+1 high clock edge. It is good practice to leave the clock in a low state when inactive because the SI pulse required to start a new cycle is a low-to-high transition.

The integration time chosen is valid as long as it falls in the range between the minimum and maximum limits for integration time. If the amount of light incident on the array during a given integration period produces a saturated output (Max Voltage output), then the data is not accurate. If this occurs, the integration period should be reduced until the analog output voltage for each pixel falls below the saturation level. The goal of reducing the period of time the light sampling window is active is to lower the output voltage level to prevent saturation. However, the integration time must still be greater than or equal to the minimum integration period.

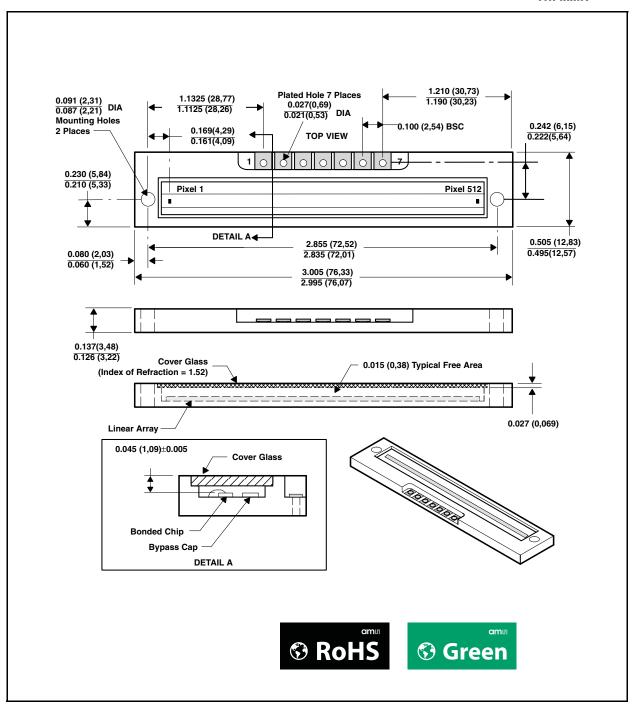
If the light intensity produces an output below desired signal levels, the output voltage level can be increased by increasing the integration period provided that the maximum integration time is not exceeded. The maximum integration time is limited by the length of time the integrating capacitors on the pixels can hold their accumulated charge. The maximum integration time should not exceed 100ms for accurate measurements.

Although the linear array is capable of running over a wide range of operating frequencies up to a maximum of 5MHz, the speed of the A/D converter used in the application is likely to be the limiter for the maximum clock frequency. The voltage output is available for the whole period of the clock, so the setup and hold times required for the analog-to-digital conversion must be less than the clock period.



Package Mechanical Data





Note(s):

- 1. All linear dimensions are in inches (millimeters).
- 2. This drawing is subject to change without notice.
- 3. Pixel centers are located along the center line of the mounting holes.



Ordering & Contact Information

Figure 14: Ordering Information

Ordering Code	Туре	Delivery Form	Delivery Quantity
TSL208R	512x1 Array	Tray	40 pcs/tray

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Document Status

Document Status	Product Status	Definition
Product Preview	Pre-Development	Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice
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Revision Information

Changes from 031G (2011-Aug) to current revision 1-00 (2016-Aug-22)	Page
Content of TAOS datasheet was converted to the latest ams design	
Added Figure 1	1

Note(s):

1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.

2. Correction of typographical errors is not explicitly mentioned.

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